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APPLICANTS

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** CONTINUING DATA *****

b. nme

** FOREIGN APPLICATIONS *****

b. JAPAN 2002-362298 12/13/2002

yes

IF REQUIRED, FOREIGN FILING LICENSE GRANTED

** 03/10/2004

Foreign Priority claimed 35 USC 119 (a-d) conditions met Verified and Acknowledged	<input checked="" type="checkbox"/> yes <input type="checkbox"/> no <input checked="" type="checkbox"/> yes <input type="checkbox"/> no <input type="checkbox"/> Met after Allowance Examiner's Signature _____ Initials _____	STATE OR COUNTRY JAPAN	SHEETS DRAWING 10	TOTAL CLAIMS 20	INDEPENDENT CLAIMS 7
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ADDRESS

22852
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TITLE

Method of selecting pattern to be measured, pattern inspection method, manufacturing method of semiconductor device,
 program, and pattern inspection apparatus

FILING FEE

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